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Characterization of LiMn_2O_4 cathodes by electrochemical strain microscopy

D. O. Alikin,¹ A. V. Ievlev,^{2,3} S. Yu. Luchkin,⁴ A. P. Turygin,¹ V. Ya. Shur,¹ S. V. Kalinin,^{2,3} and A. L. Kholkin^{1,4}

¹*Institute of Natural Sciences, Ural Federal University, 51 Lenin Ave., Ekaterinburg 620000, Russia*

²*The Center for Nanophase Materials Sciences, Oak Ridge National Laboratory, Oak Ridge, Tennessee 37831, USA*

³*Institute for Functional Imaging of Materials, Oak Ridge National Laboratory, Oak Ridge, Tennessee 37831, USA*

⁴*Physics Department and CICECO Aveiro Institute of Materials, University of Aveiro, 3810 193, Aveiro, Portugal*

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Electrochemical strain microscopy (ESM) is a scanning probe microscopy (SPM) method in which the local electrodiffusion is probed via application of AC voltage to the SPM tip and registration of resulting electrochemical strain. Here, we implemented ESM to measure local strain in bulk LiMn_2O_4 cathodes of a commercial Li-battery in different states of charge to investigate distribution of Li-ion mobility and concentration. Ramped AC ESM imaging and voltage spectroscopy were used to find the most reliable regime of measurements allowing separating and diminishing different contributions to ESM. This is not a trivial task due to complex geometry of the sample and various obstacles resulting in less predictable contributions of different origins into ESM response: electrostatic tip surface interactions, charge injection, electrostriction, and flexoelectricity. Understanding and control of these contributions is an important step towards quantitative interpretation of ESM data. © 2016 AIP Publishing LLC. [<http://dx.doi.org/10.1063/1.4943944>]

Progress in secondary batteries and fuel cells is driven by advances in the development of more efficient materials for mobile ions storage and conduction. Crucial part of this process is thorough understanding of materials properties and microelectromechanical effects associated with the intercalation and deintercalation of mobile ions. Existing and emerging scanning probe microscopy (SPM) based techniques are able to probe a wide range of functional properties of ionically conducting materials at the nanoscale.¹ Wider application and development of SPM-based techniques are important because of continuing reduction of the active particles' size, often towards the nanoscale.²

Electrochemical strain microscopy (ESM)³ is a SPM technique, which allows probing the local ionic mobility with resolution unattainable by traditional electrochemical methods.⁴ To date, the vast majority of ESM experiments were conducted on thin film samples with well defined geometry and limited number of possible contributions to the measured response.⁵ At the same time, ESM experiments on commercial Li-ion battery electrodes comprising the particles of ionic conductors embedded in a polymer binder matrix represent non-trivial problem due to complex geometry of the samples⁶ and consequent difficulties⁷ resulting in less predictable contributions of different origin into the strain response.^{8,9} From that point of view, we can generally talk about strain-based SPM (s-SPM) with a number of contributions, which must be separated in the experiments.¹⁰ Understanding and separation of these contributions is an important step from purely qualitative to quantitative data interpretation and analysis.

In this work, we measure and analyze ESM response on cross-sections of $\text{Li}_x\text{Mn}_2\text{O}_4$ cathodes with different Li concentrations and its distribution over the samples' surface.

Importantly, a complex signal dependence on distance from a current collector and state of charge of a battery was demonstrated. ESM excited with ramped AC voltage on a tip and ESM voltage spectroscopy results allowed us to show that the apparent ESM signal has a complex nature and real electrochemical contribution must be inspected carefully at low AC and DC voltages.

ESM measurements were performed on LiMn_2O_4 positive electrodes (cathodes) comprised LiMn_2O_4 ceramic particles embedded in poly(vinylidene fluoride) (PVDF) matrix with carbon black on the Al current collector (Figure 1). The electrodes were extracted from fresh cells in fully charged and discharged states, and mechanically separated from each other. A piece of the cathode was washed in dimethyl carbonate, embedded in an epoxy resin and polished. Note that even in fully charged and discharged states, remnant Li is always present in positive and negative electrodes, correspondingly. Lattice parameters of the cubic spinel $\text{Li}_x\text{Mn}_2\text{O}_4$

FIG. 1. Scanning electron microscopy image of the sample and scheme of the battery structure where fragment was cut and how ESM measurements were realized. Three regions between the Al current collector and the PVDF separator are marked.

samples were 0.8092 nm and 0.8178 nm in fully charged and fully discharged states, respectively.¹¹

The sample's area was conventionally divided into three sections between the Al current collector and the PVDF separator (Figure 1) in order to study spatial inhomogeneity of ESM response (related to Li distribution) within the cathode. A number of scans from each section (up to 10–30 particles in one section) were collected for the statistical variability.

ESM was implemented in the band excitation (BE) mode¹² using a commercial microscope (Cypher, Asylum Research) in combination with National Instruments PXI analog signal acquisition and generation electronics under ambient conditions. Samples were grounded through the metallic electrode Al current collector. Electrical contact between individual particles and Al current collector was provided by the carbon black network.

Pt coated cantilevers with about 2 N/m spring constant and 70 kHz fundamental resonance frequency were used as top moving electrodes. ESM imaging was made by applying 5–10 V AC voltage to the cantilever. Voltage spectroscopy^{13,14} with 30 V DC ramp and imaging with 30 V ramped AC at each point were additionally used.

ESM imaging and voltage spectroscopy: Figure 2 illustrates typical topography, contact resonance frequency, ESM response, and cross-section of the contact resonance frequency over the surface. The samples are composites comprising materials with significantly different mechanical properties, which give rise to resonance frequency shifts up to 30 kHz between the LiMn_2O_4 particles and the binder (Figure 2(b)). Being measured at a single frequency at the contact resonance, this effect would cause a significant crosstalk and erroneous results.¹⁵ To avoid such errors, measurements were performed in BE mode, and the ESM response was extracted after fitting the resonance curve with the single harmonic oscillator model.¹²

Assuming that averaged over a single particle ESM signal reflects the average concentration of Li ions, we compared the magnitudes of ESM signal on the surface of different particles across the sample. Figures 2(d) and 2(e) represent histograms of the ESM response acquired on the samples in lithiated (Fig. 2(d)) and delithiated (Fig. 2(e))

states over three regions I, II, and III labeled in Figure 1. The statistics was obtained by averaging ESM signal over 30–40 particles within one sample. One can see that on the lithiated sample, ESM response from regions (I) and (II) is relatively high, while response from the region (III) is notably lower. On the delithiated sample, relatively high response was observed only on the region (II), while both (I) and (III) regions showed very small and uniform response. The only difference between the samples is the concentration of mobile Li ions, so we believe that smaller response corresponds to lower Li concentration. Thus, the data in Figures 2(d) and 2(e) may represent spatial distribution of Li concentration in $\text{Li}_x\text{Mn}_2\text{O}_4$ particles between the Al current collector and the PVDF separator.

However, strain-based SPM can detect the AC electric field mediated strain of different origin: local molar volume variation due to ionic motion (Vegard contribution, or true ESM signal), piezoelectric and flexoelectric effects, and electrostriction. Resulting registered signal (S) for the ionic materials can be expressed as follows:^{5,9,20}

$$S_{1\omega} = S_{\text{Vegard}} + S_{\text{non-Vegard}}, \quad (1)$$

where the first term represents Vegard electrochemical contribution and the second non-Vegard contribution.

For the $V_{ac} \sin(\omega t)$ excitation, these contributions can be expressed as¹⁹

$$S_{\text{Vegard}} = \frac{enDV_{ac} \sin(\omega t)}{fk_B TR_0}, \quad (2)$$

where e is the elementary charge, n is the concentration of mobile ions, D is the diffusion coefficient of mobile ions, f is the AC frequency, and R_0 is the radius of the tip-sample contact area. For non-Vegard contributions, the following expression applies

$$S_{\text{non-Vegard}} = \left[\frac{2l}{l^*} Q_{33} \chi \epsilon_0 P_s^* + \frac{2}{l^*} Q_{33} \chi^2 \epsilon_0^2 V_{\text{surface}} - \frac{1}{k} \frac{\partial C(z)}{\partial z} V_{\text{surface}} \right] V_{ac} \sin(\omega t), \quad (3)$$

FIG. 2. Topography (a), BE contact resonance frequency map (b), ESM response (c) and cross section of the resonance frequency; normalized histograms of the ESM signal distribution in lithiated (d) and delithiated (e) samples.

where l is the sample thickness, P_s^* is the spontaneous polarization which exists permanently only in piezoelectrics but can appear due to flexoelectric effect and deformation potentials, Q_{33} is the electrostriction coefficient, χ is the dielectric susceptibility, l^* is the average penetration depth of E_{ac} field, $V_{surface}$ is the surface potential, and dC/dz is the capacitance gradient between the tip and the sample surface.

According to Eq. (2), Vegard contribution of ESM strain response depends on local concentration and mobility of Li ions in a material below the tip, which is determined by local diffusion coefficient. Li concentration can differ over the sample due to non-uniformity of charge/discharge process. Local diffusion coefficient may change at the grain boundaries and other microscopic defects. Additional non-Vegard contributions mentioned above^{5,16} may complicate interpretation of the response. Thus, signal distribution in Figures 2(d) and 2(e) may be related not only to Li distribution.

To resolve the problem of non-Vegard contributions, voltage spectroscopy data are usually used as an additional method of characterization.¹⁴ In this method, a series of DC voltage pulses with increasing and decreasing heights are applied to the tip. Resulting ESM response is plotted as a function of the DC voltage applied on-pulse and represents hysteresis loop (Fig. 3(c)). The main parameter, which can be extracted from the hysteresis loop, is the area in bias-strain coordinates, which is proportional to local variation of Li concentration induced during the DC voltage cycle. The map of hysteresis loop area in Fig. 3(b) (so-called “reactivity map”) looks smoother in comparison with ESM image (Fig. 3(d)) and does not show significant topography cross-talk. Signals demonstrate some similarity in distribution (Figs. 3(b) and 3(d), red marks).

In voltage spectroscopy, the ionic motion is caused not only by “fast” motion of ions induced by AC voltage but also by “slow” change of ion concentration under the tip induced by the DC voltage sweep. The area of ideal ESM hysteresis loop is believed to be a signature of the work of

local lithiation delithiation process under DC electric field. However, the loop can be closed not only when the applied DC does not change Li concentration due to lack of mobile ions but also when the strain relaxation time is smaller than the time between consequent pulses. Additional source for ambiguity is a possible local phase transition below the tip associated with the change of Li concentration during DC voltage sweep,^{9,21} which makes difficult to estimate local concentrations and diffusion coefficients from voltage spectroscopy data.

AC voltage amplitude dependences: Usually, lithiation delithiation of bulk cathode materials is performed at a low operation bias.¹⁷ In ESM, applied AC voltage directly determines the value of a registered signal, and an increase of AC voltage can significantly improve the quality of the obtained data. On the other hand, high voltage may result in the appearance of additional contributions.^{5,9,18} That is why we used ESM mapping with ramped AC voltage applied at each point to reveal how high AC voltage can influence the resulting signal. Figure 4 shows the spatial maps and extracted ESM amplitudes for both samples. ESM signal inside the particles demonstrates pronounced nonlinearity versus AC voltage, while theoretically, it is expected to be linear.¹⁹ In the lithiated sample, non-linearity appears between 3 and 5 V (Fig. 4(c)), while in the delithiated sample, it is more pronounced and appears between 15 and 20 V (Fig. 4(d)). The slope of the dependence changes in the delithiated sample, as shown in Figure 4(d) blue curve. In comparison, ESM response in PVDF matrix has a linear dependence on applied AC voltage, which indicates ferroelectric beta-phase of PVDF or electrically induced ferroelectric-like state.

One can clearly see from Eqs. (1) (3) that all contributions are linear with respect to V_{ac} . The possible explanations of obtained non-linearity is that the phase transition from the cubic $Fd3m$ $LiMn_2O_4$ to the tetragonal $I41/amd$ $Li_2Mn_2O_4$ taking place in $Li_xMn_2O_4$ at x exceeding 1 (or, strictly

FIG. 3. Topography (a), ESM response (b), example of ESM hysteresis loop (c), and map of hysteresis loop area (d) obtained over the same area of the sample. Elements on the images marked by red circle are examples of similar behavior of ESM and voltage spectroscopy.

FIG. 4. ESM images (at 10 V AC) and dependence of the ESM signal on applied AC voltage in the lithiated (a) and (c) and delithiated (b) and (d) samples. The dashed black line on (a) and (b) indicates border of individual particles. Colors of circles on (a) and (b) correspond to the colors of AC dependencies on (c) and (d). Note that ESM signal on the lithiated sample is higher (factor 10^{-4} vs 10^{-5} on the delithiated sample).

speaking, average Mn^{n+} oxidation state reduces below 3.5).²² Being driven by the electric overpotential, it can locally occur under the tip during application of high AC voltage. Higher initial Li concentration must require smaller external field leading to overlithiation and the phase transition.

If this hypothesis stands, the response before the bending of the experimental curve corresponding to the cubic phase must have sharper slope than the one in tetragonal phase, according to Vegard coefficient. To solve this contradiction, change of electrostriction coefficient or surface potential (V_{sp}) during phase transition can be assumed, but it will be rather speculative and requires additional experimental observations.

The observed behavior has one important consequence. Distribution of ESM signal in particles changes significantly when the applied voltage achieves non-linear region on experimental curve.²¹ Thus, results measured only at a fixed AC voltage may have different interpretation depending on the voltage. To extract spatial distribution of characteristic response-excitation curves from spectroscopic data, we used principle component analysis (PCA) and k-means clustering.^{23–25} Similar approach was recently used for statistical analysis of the micro-Raman data.^{26,27} PCA allows automated deconvolution of the vectors set A_i (ESM response vs AC voltage curves) on the linear combination of orthogonal uncorrelated eigenvectors v_k with weight/loading coefficients l_{ik}

$$A_i = l_{ik}v_k. \quad (4)$$

Then eigenvectors are sorted in a descending order by variance. The first eigenvector contains the most statistically important information about system behavior, second the most important information after subtraction of the first one, and so on. In this manner, important patterns of system behavior are characterized by a few first eigenvectors and set

of the corresponding loadings,²¹ while last eigenvectors are defined by noise and distortions only. Application of the k-means clustering in multidimensional space formed by PCA weight coefficients allowed us to plot a map of the regions with fundamentally different spectra (Fig. 5). Note that PCA is performed on the three-dimensional dataset of ESM response as a function of amplitude of the applied AC voltage and spatial position. It clearly shows that non-linearity in ESM signal is localized only in several regions of the particle. These facts must be taken into consideration when comparing the results. Otherwise, different mechanisms of underlying response can be wrongly interpreted as equal.

In conclusion, in this work, we implemented ramped AC voltage ESM imaging and voltage spectroscopy to study local Li activity and its variation as a function of Li concentration. Non-uniform distribution of the response signal on LiMn_2O_4 particles was shown and attributed to different electrochemical activity of lithium in different regions of a particle. At the same time, it was experimentally shown that s-SPM response cannot be simply interpreted as proportional to mobility of Li ions due to multiple non-Vegard contributions including electrostatic forces, charge injection, and electrostriction. Distribution of ESM signal was found to change significantly with increase of AC amplitude, which was attributed to the phase transition from cubic $\text{Fd}3\text{m}$ LiMn_2O_4 to tetragonal $\text{I}41/\text{amd}$ $\text{Li}_2\text{Mn}_2\text{O}_4$ phases accompanied by the Jahn Teller distortion. Proposed analysis of ESM signal distribution by principal components analysis allows distinguishing regions in particles with different signal behavior.

These results demonstrate that the voltage during ESM measurements must be carefully controlled to avoid undesirable contributions of the electromechanical non-Vegard coupling. Further theoretical development and experiments are required for the qualitative analysis of the observed phenomena.

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FIG. 5. Results of the automated k means clustering performed for the ESM images with linearly increasing AC voltage. Map of regions with different ESM signal behavior in the lithiated (a) and delithiated (b) sample, and correspondent average AC dependences (c) and (d). Colors on (a) and (b) correspond to colors on (c) and (d).

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